



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Young Hoon Kwark

Examiner: Emily Y. Chan

Serial No: 10/769,115

Group Art Unit: 2829

Filed: January 30, 2004

Docket: YOR20030625US1 (163-27)

For: CONTACTLESS CIRCUIT TESTING FOR ADAPTIVE WAFER PROCESSING

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

AMENDMENT UNDER 37 C.F.R. §1.111

Sir:

This is a response to the Office Action mailed August 24, 2005. Please amend the above-identified application as follows:

CERTIFICATE OF MAILING 37 C.F.R. §1.8(a)

I hereby certify that this correspondence (and any document referred to as being attached or enclosed) is being deposited with the United States Postal Service as first class mail, postage paid in an envelope addressed to: Mail Stop Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on 11/22/05.

James J. Bitetto